

Search Notes**Application/Control No.**

10/829,248

Examiner

ALEX LIEW

**Applicant(s)/Patent under
Reexamination**

NAKASHIMA ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/103,104,107,115-118,124-127 limited to text search	8/10/2008	AL